FAIRCHILD SEMICONDUCTOR®

January 2011

FPF2700 / FPF2701 / FPF2702 — AccuPower™ 0.4~2A Adjustable Over-Current Protection Load Switches

Features

- 2.8V to 36V Input Voltage Range
- Typical $R_{DS(ON)}$=88mΩ
- 0.4A to 2A Adjustable Current Limit (Min.)
- Slew Rate Controlled
- ESD Protected, above 2000V HBM
- Thermal Shutdown
- Active LOW Enable
- UVLO Protection
- Power-Good Output

Applications

- Motor Drives
- Digital Cameras
- Consumer Electronics
- Industrial
- Computing
- Hard Disk Drives
- Telecom Equipment



Figure 1. MLP (Top View)



Figure 2. MLP (Bottom View)



Figure 3. SO8 (Top View)

Description

The AccuPower™ FPF270X series is a family of current-limit load switches that provide full protection to systems and loads from excess current conditions. Minimum current limit is adjustable from 0.4A to 2.0A. The FPF270X contains a slew-rate-controlled N-channel MOSFET and slew-rated turn-on to prevent power bus disturbances from being caused by “hot plugging” loads or momentary excess load demands. The input voltage range is 2.8V to 36V. Loads can be activated or deactivated with a low-voltage logic-compatible ON pin. Fault conditions can be monitored using the error flag pin and/or the power-good pin.

Each member of the FPF270X family serves a category of load-fault response. All devices clamp the load current so that it cannot exceed an externally programmed current level. An over temperature feature provides further device protection in case of excessive levels of power dissipation.

FPF2700 responds to an overload condition that lasts longer than a fixed blanking period by turning off the load, followed by a retry after the auto-restart time.

FPF2701 responds to an overload condition that lasts longer than a fixed blanking period by latching off the load. The load remains off unless either the ON pin is toggled or the input voltage cycles through UVLO.

FPF2702 is intended to be used with external fault management. Like the FPF2700 and FPF2701, it sets the fault signal pin LOW when it activates current clamping. This device is intended for applications where external fault management coordinates the overload response with the FPF2702.

The FPF270X is available in a space-saving Pb and Halogen free, 8-lead MLP 3x3mm and SO8 packages.

Ordering Information

Part Number	Current Limit [A]	Current Limit Blanking Time [ms]	Auto-Restart Time [ms]	ON Pin Activity	Package
FPF2700MPX	0.4 – 2.0	0.5	127.5	Active LOW	MLP3X3
FPF2701MPX	0.4 – 2.0	0.5	NA	Active LOW	MLP3X3
FPF2702MPX	0.4 – 2.0	NA	NA	Active LOW	MLP3X3
FPF2700MX	0.4 – 2.0	0.5	127.5	Active LOW	SO8
FPF2701MX	0.4 – 2.0	0.5	NA	Active LOW	SO8
FPF2702MX	0.4 – 2.0	NA	NA	Active LOW	SO8

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Application Diagram

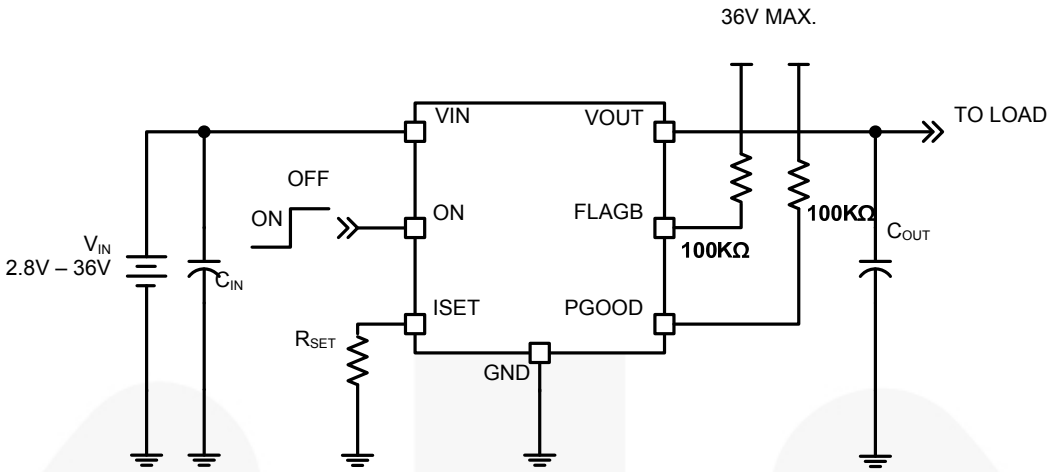


Figure 4. Typical Application

Block Diagram

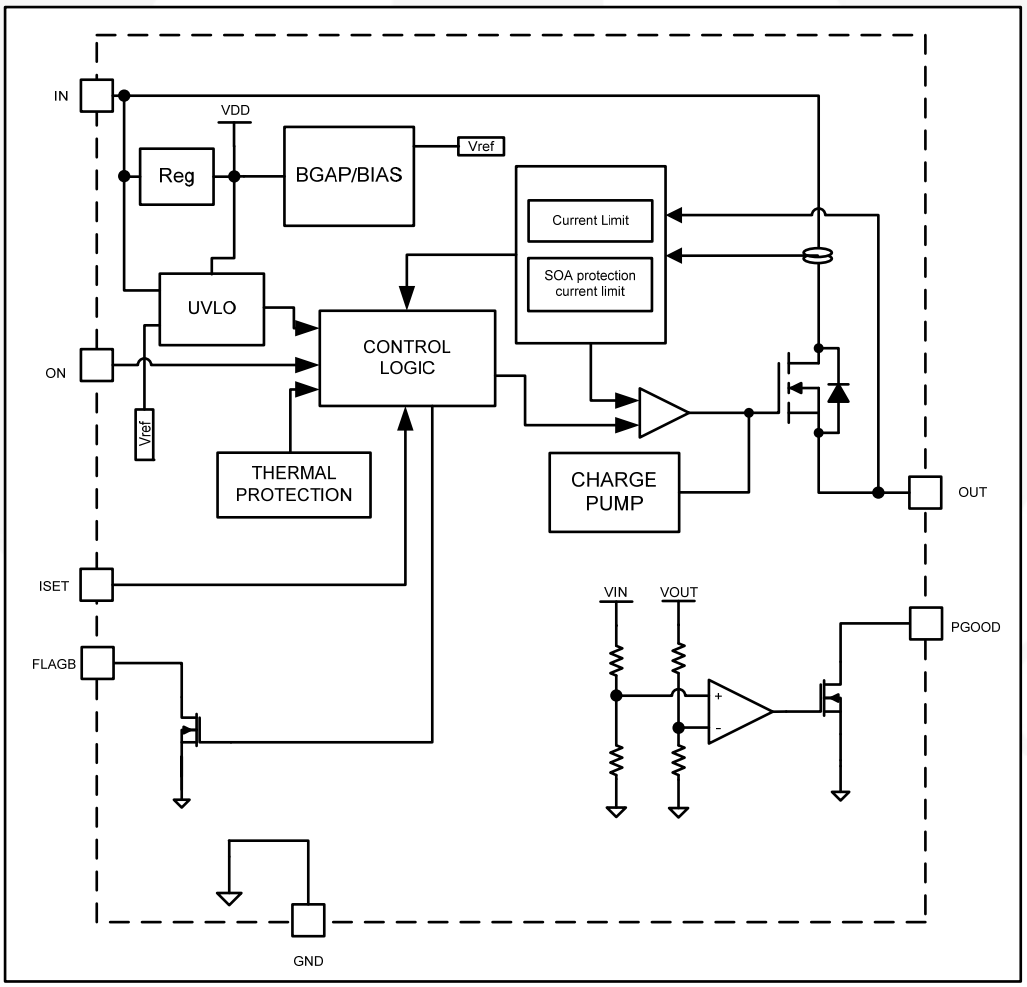


Figure 5. Block Diagram

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Pin Configurations

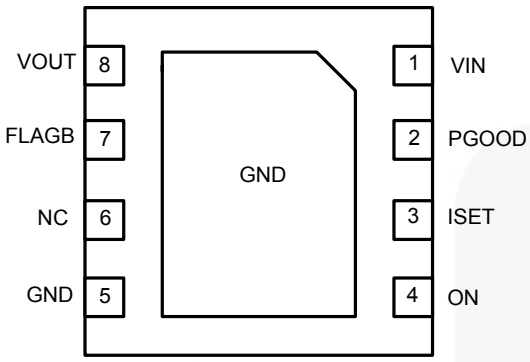


Figure 6. MLP (Bottom View)

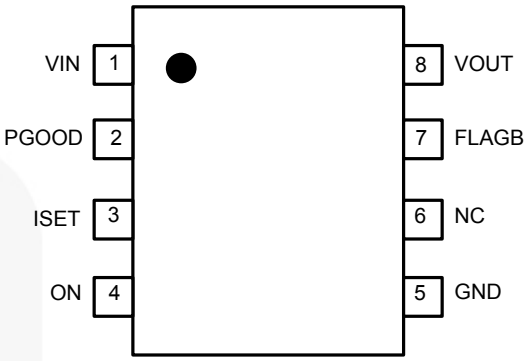


Figure 7. SO8 (Top View)

Pin Definitions

Pin #	Name	Description
1	VIN	Supply Input. Input to the power switch and the supply voltage for the IC.
2	PGOOD	Power-Good Output. Open-drain output to indicate that output voltage has reached 90% of input voltage.
3	ISET	Current Limit Set Input. A resistor from ISET to ground sets the current limit for the switch.
4	ON	ON Control Input. Active LOW.
5	GND	Ground
6	NC	No connection. Leave open or connect to ground.
7	FLAGB	Fault Output. Active LOW, open-drain output that indicates current limit, under-voltage, or over -temperature state.
8	VOUT	Switch Output. Output of the power switch.

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Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter		Min.	Max.	Unit
	PGOOD, FLAGB, VIN to GND		-0.3	40	V
	VOUT to GND		-0.3	V_{IN} + 0.3	V
	ON to GND		-0.3	6	V
P_D	Power Dissipation (T_A=25°C)	MLP 3x3[1], *See Figure 8*		1.25	W
		SO8[1], *See Figure 10*		1.00	
I_{SW}	Maximum Continuous Switch Current			3.5	A
T_J	Operating Junction Temperature		-40	+125	°C
T_{STG}	Storage Temperature		-65	+150	°C
ESD	Electrostatic Discharge Protection Level	Human Body Model, JESD22-A114	2000		V
		Charged Device Model, JESD22-C101	2000		
Θ_{JA}	Thermal Resistance, Junction to Ambient	MLP 3x3[1], *See Figure 8*		80	°C/W
		SO8[1], *See Figure 10*		102	

Note:

1. Thermal resistance, θ_{JA}, is determined with the device mounted on a one inch square pad, 2oz copper pad, and a 1.5 x 1.5in. board of FR-4 material.

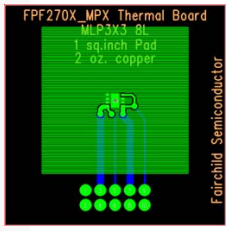


Figure 8. 80°C/W Mounted on a 1in² Pad of 2oz. Copper

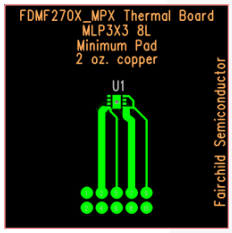


Figure 9. 226°C/W Mounted on a Minimum Pad of 2oz. Copper

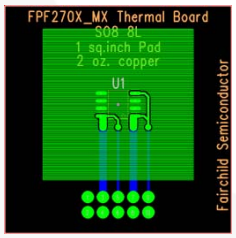


Figure 10. 102°C/W mounted on a 1in² Pad of 2oz. Copper

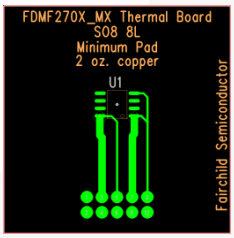


Figure 11. 181°C/W Mounted on a Minimum Pad of 2oz. Copper

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Min.	Max.	Unit
V_{IN}	Input Supply Voltage	2.8	36.0	V
T_A	Ambient Operating Temperature	-40	85	°C

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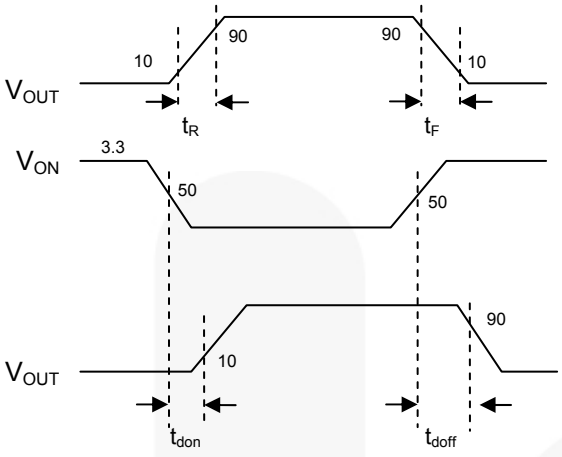
Electrical Characteristics

V_{IN}=2.8 to 36V and T_A=-40 to +85°C unless otherwise noted. Typical values are at V_{IN}=12V and T_A=25°C.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Basic Operation						
V_{IN}	Operating Voltage		2.8		36.0	V
I_Q	Quiescent Current	V_{IN}=12V, V_{ON}=0V, I_{OUT}=0A		92	140	µA
I_{SHDN}	Shutdown Current	V_{IN}=36V, V_{ON}=3.3V, I_{OUT}=0A		5	14	µA
R_{ON}	On-Resistance	T_A=25°C, V_{IN}=12V		88	114	mΩ
		T_A=-40 to +85°C, V_{IN}=12V			140	
		T_A=25°C, V_{IN}=5V		88	114	
		T_A=-40 to +85°C, V_{IN}=5V			140	
V_{IH}	ON Input Logic HIGH Voltage	V_{IN}=2.8 to 36V	2.0			V
V_{IL}	ON Input Logic LOW Voltage	V_{IN}=2.8 to 36V			0.8	V
I_{LK}	ON Input Leakage	V_{ON}=5.5V or GND	-1		1	µA
I_{SWOFF}	Off Switch Leakage	V_{IN}=36V, V_{ON}=3.3V, V_{OUT}=0V		0.01		µA
$V_{FLAGB(LO)}$	FLAGB Output Logic LOW Voltage	V_{IN}=5V, I_{SINK}=1mA		0.1	0.2	V
$I_{FLAGB(HI)}$	FLAGB Output Logic HIGH Leakage Current	V_{IN}=36V, Switch On, V_{FLAGB}=36V			1	µA
V_{PGOOD}	PGOOD Trip Voltage	V_{IN}=5V, V_{OUT} as Percent of V_{IN}, V_{OUT} Rising		90		%
$V_{PGOOD(HYS)}$	PGOOD Hysteresis	V_{IN}=5V, V_{OUT} as Percent of V_{IN}, V_{OUT} Falling		3		%
$V_{PGOOD(LO)}$	PGOOD Output Logic LOW Voltage	V_{IN}=5V, I_{SINK}=1mA		0.1	0.2	V
$I_{PGOOD(HI)}$	PGOOD Output High Leakage Current	V_{IN}=36V, Switch ON, V_{PGOOD}=36V			1	µA
Protections						
I_{LIM}	Current Limit	T_A=25°C	0.8 x I_{NOM}	1.0 x I_{NOM}	1.2 x I_{NOM}	A
I_{SC}	Short Circuit Current Limit	V_{OUT} < 2V, Switch in Over-Current Condition		0.75 x I_{NOM}		A
TSD	Thermal Shutdown	Shutdown Threshold		140		°C
		Return from Shutdown		110		
		Hysteresis		30		
UVLO	Under-Voltage Shutdown	V_{IN} Increasing	2.3	2.5	2.7	V
$UVLO_{_HYST}$	Under-Voltage Shutdown Hysteresis			100		mV
Dynamic						
t_{don}	Turn On Delay	R_L=500Ω, C_L=2uF		2.7		ms
t_{doff}	Turn Off Delay			0.1		
t_R	V_{OUT} Rise Time			7.5		
t_F	V_{OUT} Fall Time			1.5		
t_{BLANK}	Over-Current Blanking Time	FPF2700/1, T_A=25°C	0.25	0.50	0.75	ms
$t_{RESTART}$	Auto-Restart Time	FPF2700, T_A=25°C	63.8	127.5	191.2	ms
t_{CLR}	Current-Limit Response Time	V_{IN}=12V, V_{ON}=0V		50		µs

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Timing Diagram



$t_{ON} = t_R + t_{don}$ $t_{OFF} = t_F + t_{doff}$

Figure 12. Timing Diagram

Typical Performance Characteristics

V_{IN} = 12V and T_A = 25°C.

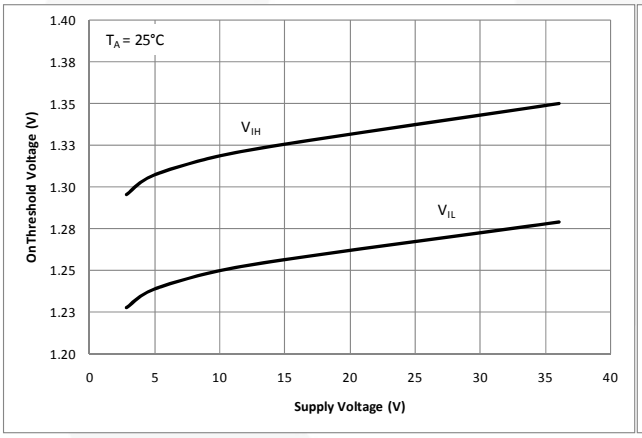


Figure 13. ON Threshold vs. Supply

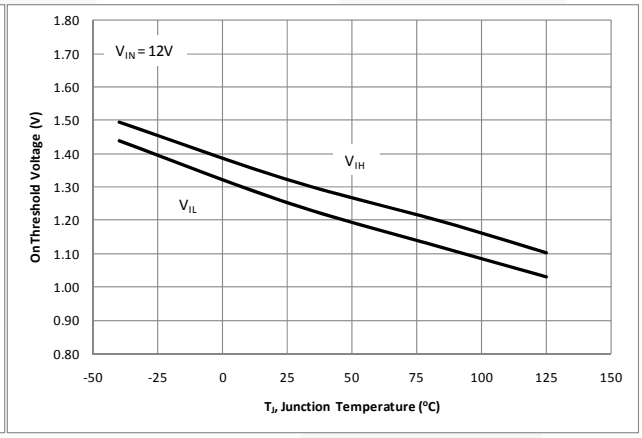


Figure 14. ON Threshold vs. Temperature

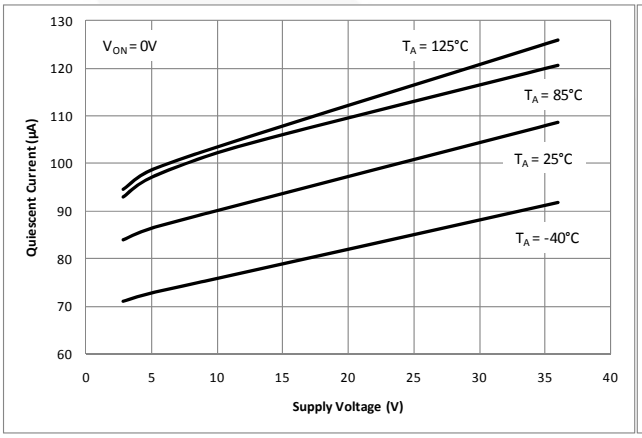


Figure 15. Quiescent Current vs. Supply Voltage (ON)

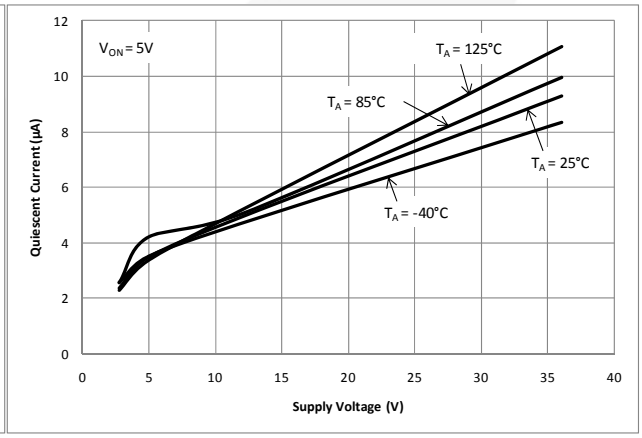


Figure 16. Quiescent Current vs. Supply Voltage (OFF)

Typical Performance Characteristics

V_{IN} = 12V and T_A = 25°C.

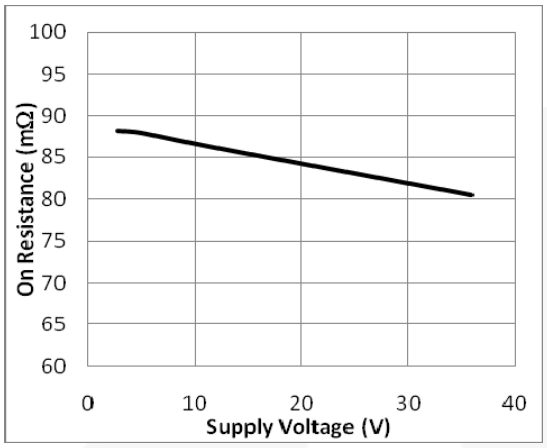


Figure 17. On Resistance vs. Supply Voltage

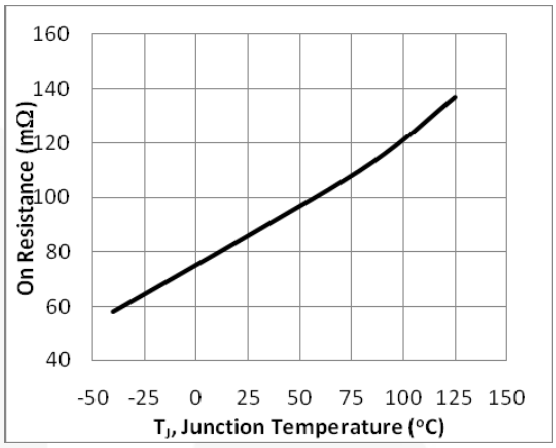


Figure 18. On Resistance vs. Junction Temperature

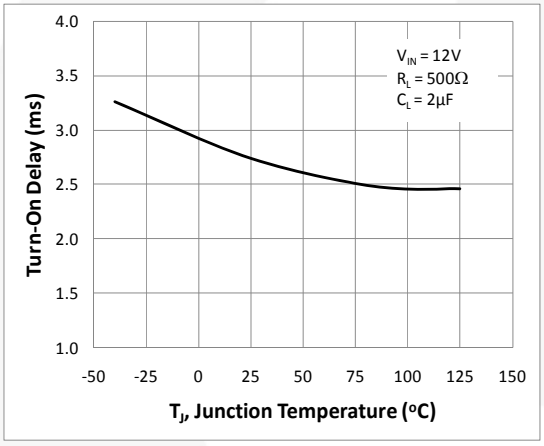


Figure 19. Turn-On Delay vs. Junction Temperature

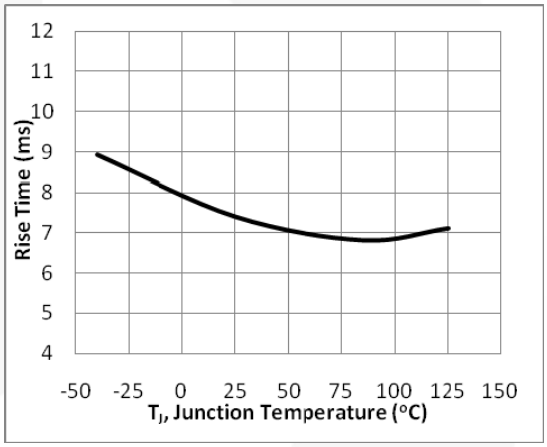


Figure 20. Output Rise Time vs. Junction Temperature

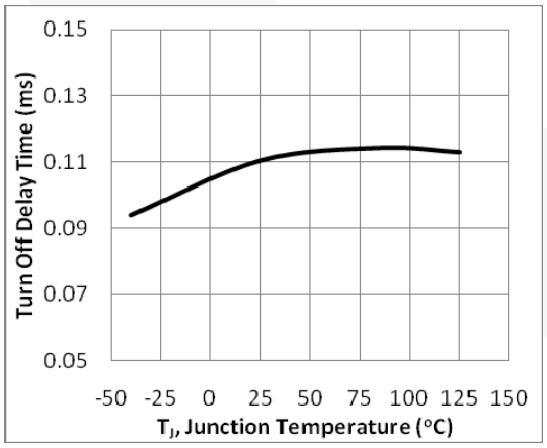


Figure 21. Turn-Off Delay vs. Junction Temperature

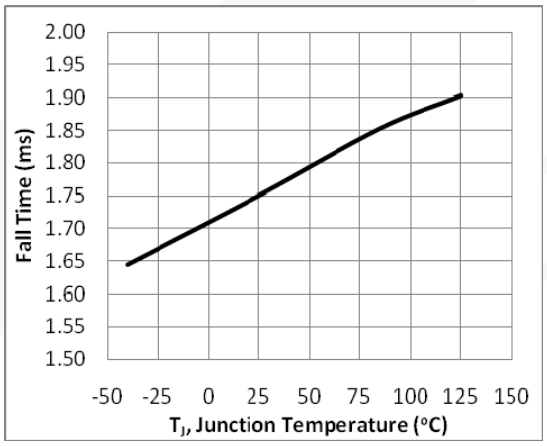


Figure 22. Output Fall Time vs. Junction Temperature

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Typical Operation Characteristics of FPF2700 and FPF2701

When V_{OUT}<2V, the current limit is set to 75% of I_{LIM}.

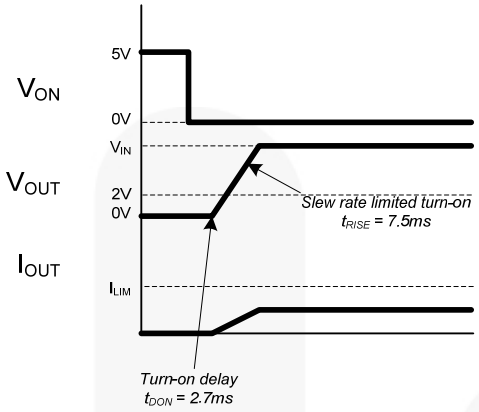


Figure 23. Normal Startup to 0.5X I_{LIM}

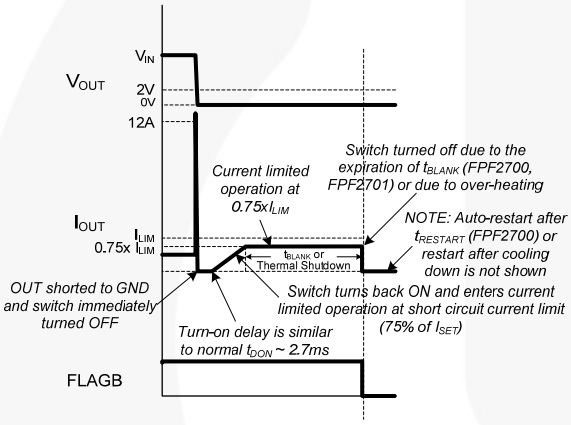


Figure 24. OUT Shorted to GND, Short Condition Persists (SOA Protection Followed by Current-Limited Operation)

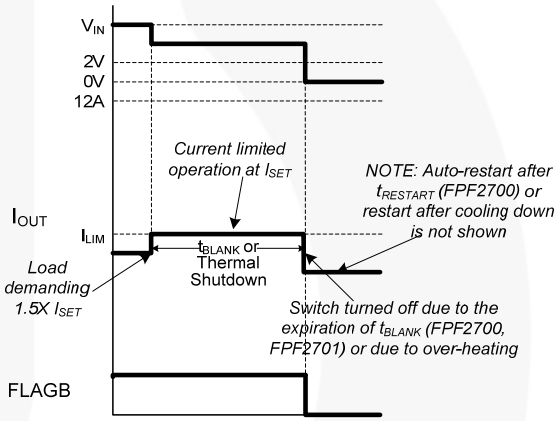


Figure 25. OUT Overloaded with 1.5X I_{LIM} (Long-Duration Overload)

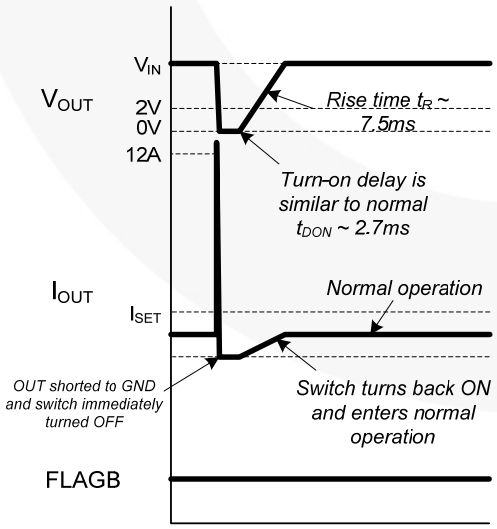


Figure 26. OUT Shorted to GND, Short Condition Removed (SOA Protection Followed by Normal Operation)

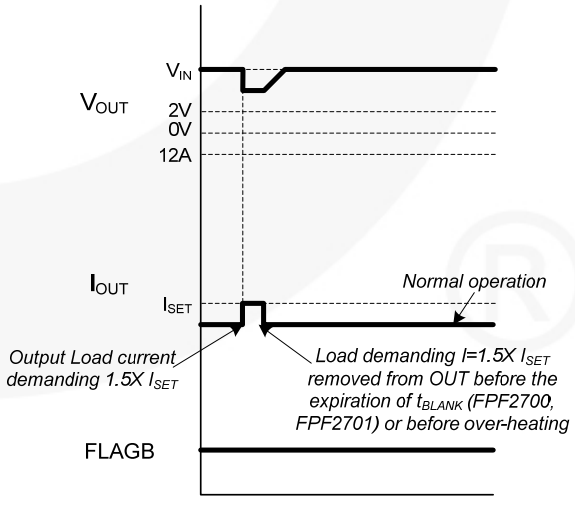


Figure 27. OUT Overloaded with 1.5X I_{LIM} (Transient Overload)

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Typical Operation Characteristics of FPF2702

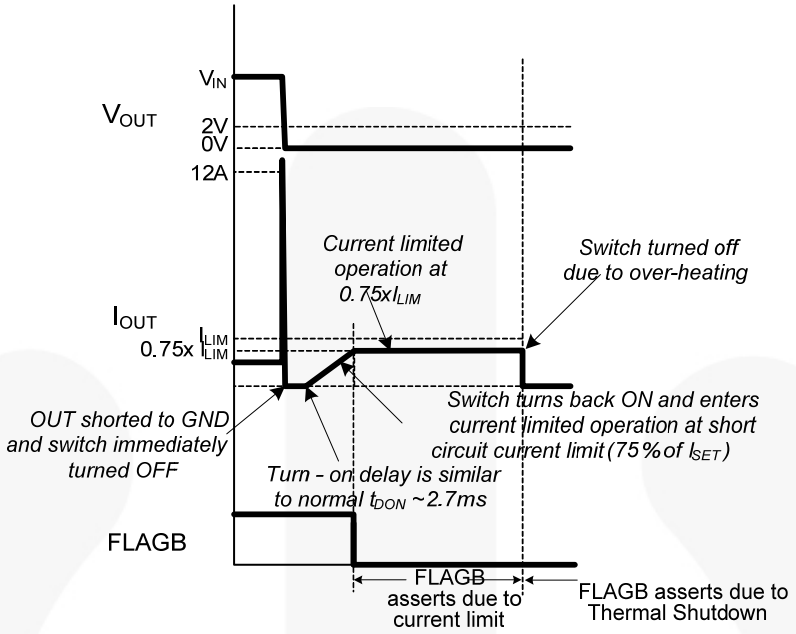


Figure 28. OUT Shorted to GND, Short Condition Persists (SOA Protection Current Limit Followed by Current Limit)

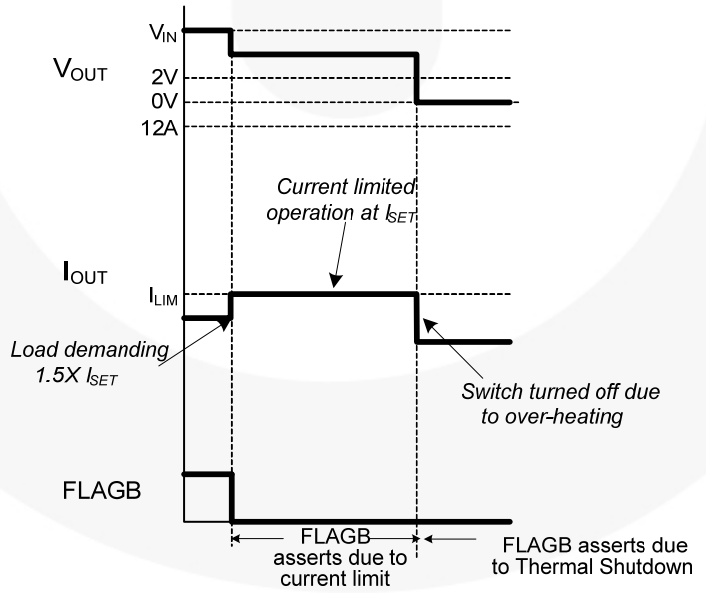


Figure 29. OUT Overloaded with 1.5X I_{LIM} (Long-Duration Overload)

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Typical Performance Characteristics FPF270X

V_{IN} = 12V and T_A = 25°C.

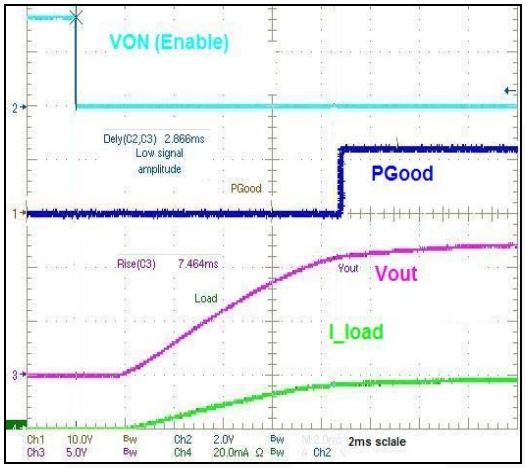


Figure 30. 12V Turn-On Delay (R_L=500Ω, C_{OUT}=2μF)

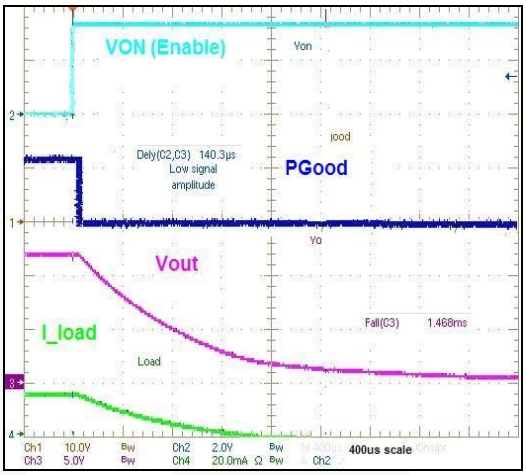


Figure 31. 12V Turn-Off Delay (R_L=500Ω, C_{OUT}=2μF)

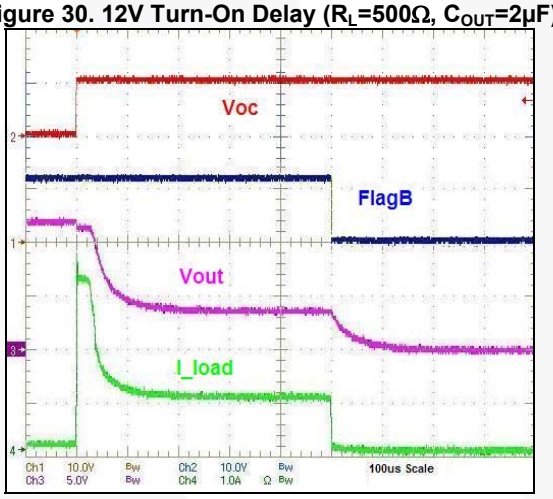


Figure 32. 12V Blanking Time (Output Overloaded and t_{blank} Expired, FPF2700/01, I_{LIM}=1A, I_{LOAD}=3.3A, C_{OUT}=μF, R_{LOAD}=500Ω) V_{OC} (2)

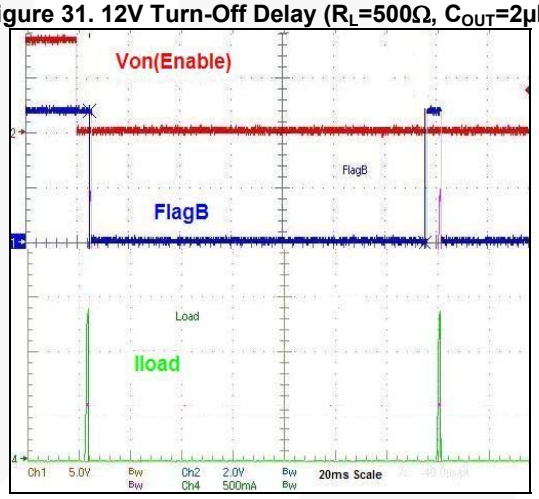


Figure 33. 12V Restart Time (Switch Turned ON into Persistent Over-Current Condition,$t_{RESTART}$~127.5ms)

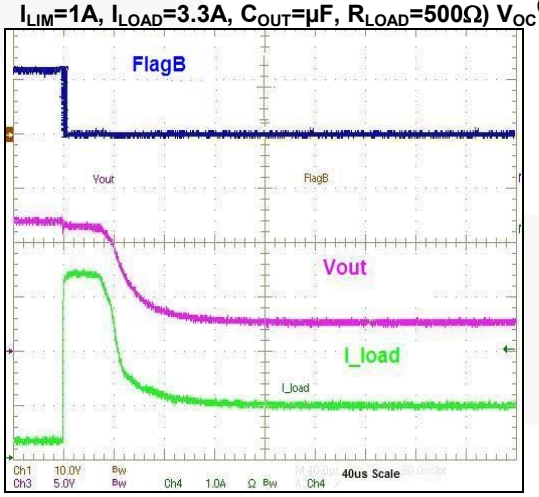


Figure 34. Soft Overload and Constant Current (I_{LOAD} > I_{LIM}, FPF2702 Enters Constant Current Mode, Running at I_{LIM})

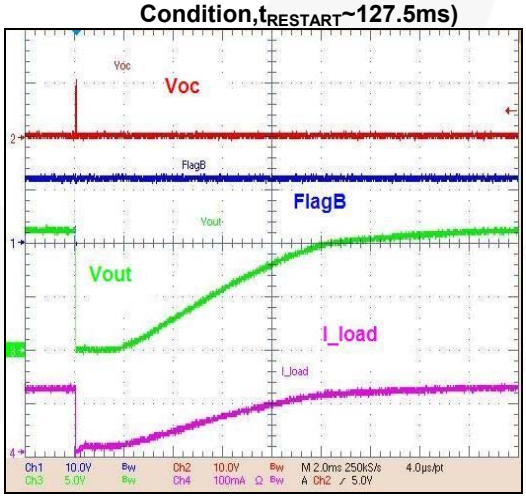


Figure 35. OUT Shorted to GND, Short Condition Removed (SOA Protection Followed by a Normal Operation, FPF2700 / FPF2701)

Note:

2. V_{OC} signal forces the device into an over-current condition by loading a 500mΩ resistor to the output through an NMOS. V_{OC} is the gate drive of the NMOS.

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Application Information

Description of Operation

The FPF270X family of current limit load switches is designed to meet the power requirements of a variety of applications with wide input voltage range of 2.8V to 36V and adjustable current-limit value. The FPF270X family offers control and protection while providing optimum operation current for safe design practices. The core of each switch is a typical 88mΩ (V_{IN} = 12V) N-channel MOSFET and a controller capable of functioning over an input voltage range of 2.8V to 36V.

FPF270X offers adjustable current limiting, under-voltage lockout (UVLO), power-good indicator (PGOOD), fault flag output (FLAGB), and thermal shutdown protection. In the event of an over-current condition, the load switch limits the load to the current limit value. The current limit value for each switch can be adjusted from 400mA to 2A through the ISET pin.

On/Off Control

The ON pin is active LOW for and controls the state of the switch. Pulling the ON pin continuously to LOW holds the switch in ON state. The switch moves into OFF state when the ON pin is pulled HIGH. The ON pin can be pulled HIGH to a maximum voltage of 5.5V.

An under-voltage condition on the input voltage or a junction temperature in excess of 140°C overrides the ON control and turns off the switch. In addition, an over-current condition causes the switch to turn off in the FPF2700 and FPF2701 after the expiration of the blanking time. The FPF2700 has an auto-restart feature that automatically turns the switch ON again after the auto-restart time. For the FPF2701, the ON pin must be toggled to turn the switch on again. The FPF2702 does not turn off in response to an over-current condition; it remains operating in Constant-Current Mode as long as ON is enabled and the thermal shutdown or UVLO have not activated. The ON pin does not have internal pull-down or pull-up resistors and should not be left floating.

Fault Reporting

Upon detection of an over-current condition, an input UVLO, or an over-temperature condition, the FLAGB signals the Fault Mode by activating LOW. In the event of an over-current condition for the FPF2700 or FPF2701, the FLAGB goes LOW at the end of the blanking time (Figure 24 and Figure 25). FLAGB goes LOW immediately for the FPF2702 (Figure 29). If the over-current condition lasts longer than blanking time, FLAGB remains LOW through the auto-restart time for the FPF2700. For the FPF2701, FLAGB is latched LOW and ON must be toggled to release it.

For FPF2702, FLAGB is LOW during a fault and immediately returns HIGH at the end of the fault condition. FLAGB is an open-drain MOSFET that requires a pull-up resistor. The maximum pull-up voltage is 36V (Figure 29).

During shutdown, the pull-down on FLAGB is disabled to reduce current draw from the supply. A 100KΩ pull-up resistor is recommended in the application.

Current Limiting

The current limit ensures that the current through the switch doesn't exceed a maximum value while not limiting at less than a minimum value. The current-limit level is adjustable through an external resistor connected between the ISET pin and GND.

The typical current limit level is adjustable from 500mA to 2.5A. The minimum current limit ($I_{LIM(MIN)}$) range is from 0.4A to 2.0A, including 20% current-limit tolerance. The FPF2700 and FPF2701 have a blanking time during which the switch acts as a constant-current source (Figure 27). If the over-current condition persists beyond the blanking time, the FPF2700 latches off and shuts the switch off (Figure 32). If the ON pin is kept active, an auto-restart feature releases the switch and turns the switch on again after the auto-restart time (Figure 33). If the over-current condition persists beyond the blanking time, the FPF2701 latch-off feature shuts the switch off. The switch is kept off until the ON pin is toggled or input power is cycled. The FPF2702 has no current-limit blanking period, so it remains in a constant-current state until the ON pin is deactivated or the thermal shutdown turns off the switch.

Besides the current-limiting functionality, the switch is protected by the thermal shutdown protection and an independent SOA protection circuit is available.

SOA Protection Current Limit (I_{OUT} > 12A)

FPF270X has an SOA protection feature to protect the load switch in response to current surges exceeding 12A in normal operation. If a short-circuit event occurs (I_{OUT}>12A), the switch is turned off in about 1µs by an independent Safe Operating Area (SOA) protection circuit (Figure 26, Figure 28). This feature protects the switch in case of sudden, high-current events at the output, such as a short to GND. The switch turns on automatically after a turn-on delay of about 2.7ms.

Short-Circuit Current Limit (V_{OUT} < V_{SCTH} = 2V)

When the output voltage drops below the short-circuit threshold voltage, V_{SCTH}, the current-limit value re-conditions itself to the short-circuit current limit value, which is 75% of the nominal current limit (0.75 x $I_{LIM,}$) (Figure 24). This prevents early thermal shutdown by reducing the power dissipation of the device. The V_{SCTH} value is set at 2V. At about V_{OUT} = 2.1V, the switch is removed from short-circuit current-limiting mode and the current limit is set to the nominal current limit value.

Setting the Current Limit Value

The FPF270X has an adjustable 0.4A to 2.0A minimum current limit set through an external resistor, R_{SET}, connected between ISET and GND. A precision R_{SET} value must be used, such as 1% tolerance or lower, to minimize the total current limit tolerance of the system.

Use the following equation to calculate the value of the resistor for intended typical current limit value:

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$$R_{SET}(K\Omega) = \frac{277.5}{I_{LIM(TYP)}(A)} \quad (1)$$

$I_{LIM(TYP)}$ is the typical current limit value based on a given R_{SET}.

Table 1. R_{SET} Selection Guide

R_{SET} (kΩ)	Current Limit [A]			Tol. (%)
	Min.	Typ.	Max.	
111	2.00	2.50	3.00	20
124	1.79	2.24	2.69	20
147	1.51	1.89	2.27	20
182	1.22	1.52	1.83	20
220	1.01	1.26	1.51	20
274	0.81	1.01	1.22	20
374	0.59	0.74	0.89	20
549	0.40	0.51	0.61	20

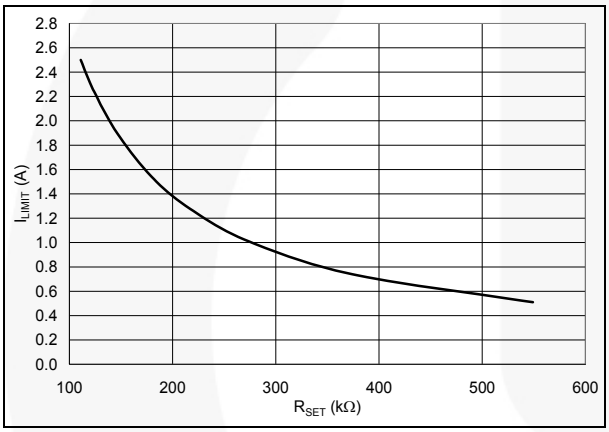


Figure 36. I_{LIM} vs. R_{SET}

Under-Voltage Lockout (UVLO)

The under-voltage lockout feature turns off the switch if the input voltage drops below the under-voltage lockout threshold. With the ON pin active (ON pin pulled LOW), the input voltage rising above the under-voltage lockout threshold causes a controlled turn-on of the switch (Figure 37). The UVLO threshold voltage is set internally at 2.5V for V_{IN} rising. The under-voltage lockout threshold has a 0.1V hysteresis.

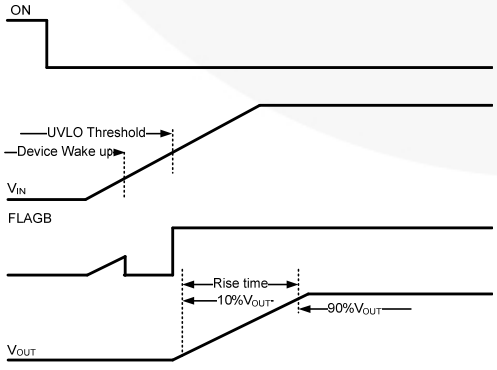


Figure 37. Under-Voltage Lockout Performance

Power Good

FPF270X has a power good feature. The PGOOD pin is an open-drain MOSFET that asserts HIGH when the output voltage reaches 90% of the input voltage (Figure 26). A typical 3% PGOOD hysteresis is added to PGOOD to prevent PGOOD from chattering as V_{OUT} falls near the PGOOD threshold voltage.

The PGOOD pin requires an external pull-up resistor connected to an external voltage source compatible with input levels of other chips connected to this pin. PGOOD is kept LOW when the device is inactive. To save current in the OFF state, the pull-up resistor of the PGOOD pin can be connected to the output voltage when there is no battery, provided that compatibility with the input levels of other devices connected to PGOOD is observed. A typical value of 100kΩ is recommended for the pull up resistor. When the power-good feature is not used in the application, the PGOOD pin can be connected to GND.

Thermal Shutdown

Thermal shutdown protects the die from internally or externally generated excessive temperatures. During an over-temperature condition; as the temperature increases above 140°C, FLAGB is activated and the switch is turned off.

When the die cools down sufficiently (die temperature drops below the threshold level), the switch automatically turns on again. To avoid unwanted thermal oscillations, a 30°C (typical) thermal hysteresis is implemented between thermal shutdown entry and exit temperatures. Proper board layout is required to prevent premature thermal shutdown *(see Figure 38 for thermal shutdown behavior on FPF2702)*.

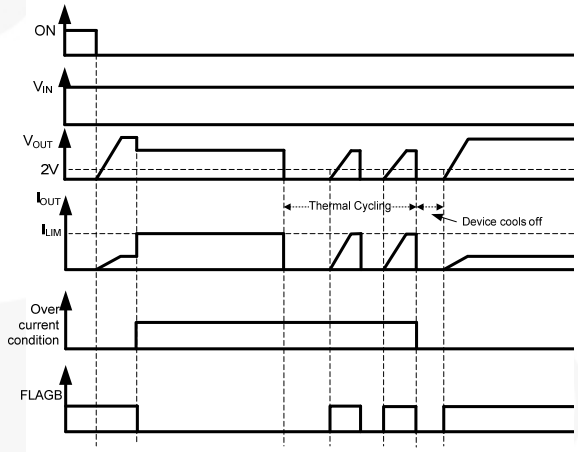


Figure 38. FPF2702 Thermal Shutdown Behavior

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SOA (FPF2702)

During extended output-short conditions, excessive power dissipation occurs in the load switch. FPF2700 and PFP2701 are protected by turning off the load switch after blanking time. FPF2702 has no blanking time feature; please refer to Note 3.

It is possible to estimate the SOA for the two FPF2702 packages, MPX and MX, through their respective SOA curves shown in Figure 39 and Figure 40. These curves provide a reference on how long the load switch survives under the worst-case scenario with minimum pad size of one square inch.(1)

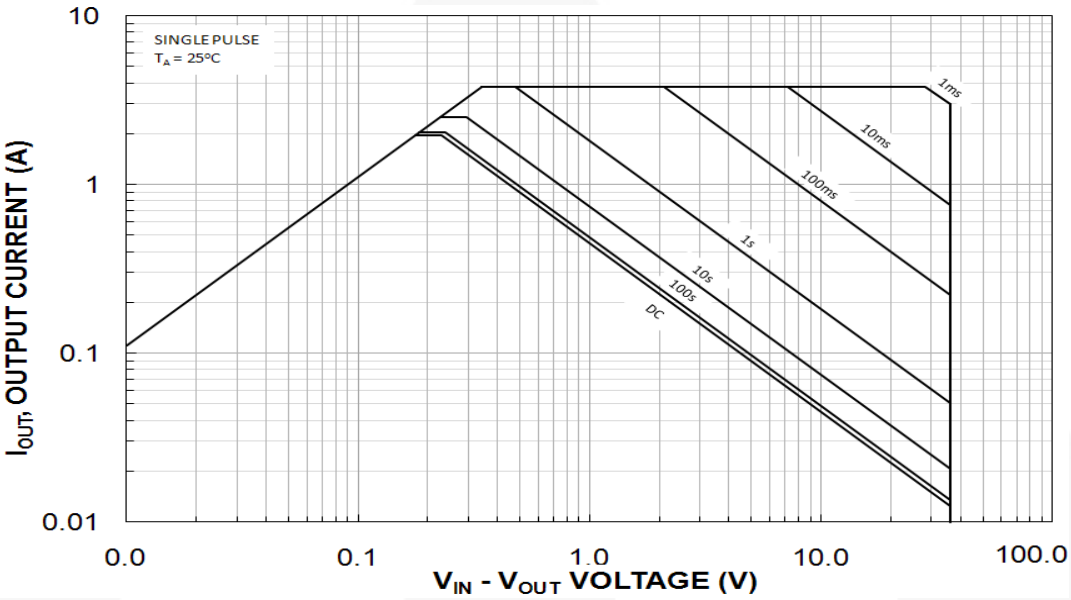


Figure 39. FPF2702 MPX SOA

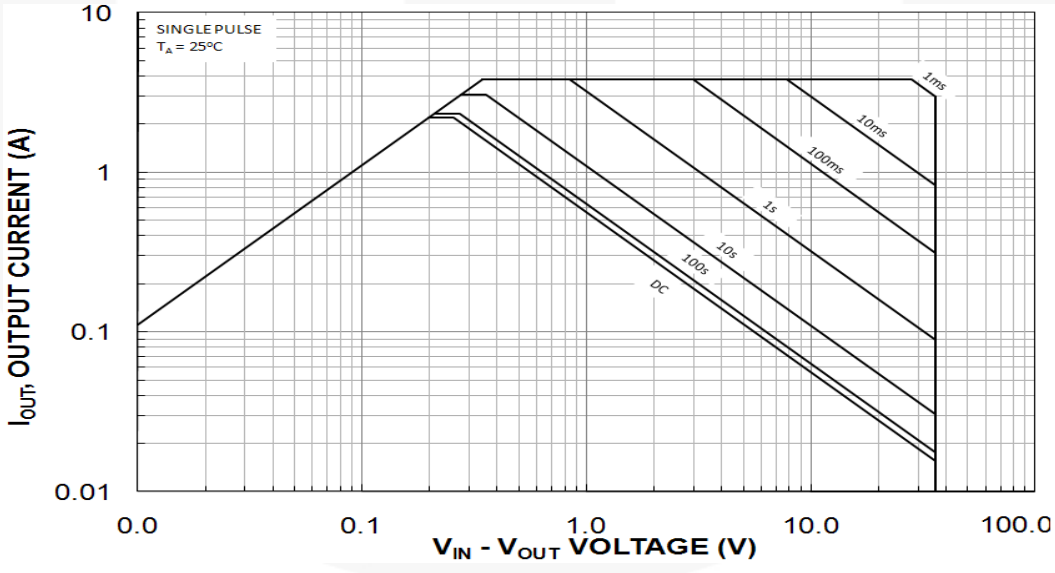


Figure 40. FPF2702 MX SOA

Note:

3. To protect FPF2702 from an extended short condition, additional protection must be implemented in the system to protect the device. For example, the FLAGB and PGOOD signal can be used to monitor the short-circuit fault condition. In applications where FPF2702 can be exposed to persistent short-circuit conditions, it should be used only with external fault management control to protect the switch.

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Input Capacitor

To limit the voltage drop on the input supply caused by transient inrush currents when the switch is turned on into a discharged load capacitor or short-circuit; an input capacitor, C_{IN}, is recommended between the IN and GND pins. The FPF270X features a fast current limit response time (50µs). During this period, the device relies on the input capacitor to supply the load current. A 10µF to 100µF ceramic capacitor is adequate for C_{IN} in most cases. Larger C_{IN} values may be required in high-voltage or high-current applications. An electrolytic capacitor can be used in parallel to further reduce the voltage drop.

Output Capacitor

A 0.1µF to 1µF capacitor, C_{OUT}, should be placed between the OUT and GND pins. This capacitor helps prevent parasitic board inductances from forcing the output voltage below ground when the switch turns off. This capacitor should have a low dissipation factor. An X7R Multilayer Ceramic Chip (MLCC) capacitor is recommended.

During startup, the total output current consists of both the load current and the charge current of the output capacitor. For the FPF2700 and FPF2701; if the total output current exceeds the set current limit threshold (determined via R_{SET}) for longer than the blanking time, the device may not be able to start properly. This imposes an upper limit to the value of the output capacitor, given the load current and the selected current limit value. C_{OUT} should not exceed the C_{OUTmax} calculated in Equation 2 or the switch does not start properly due to the set current limit:

$$C_{OUT\,max} \le I_{LIM_MIN} \times 500\mu s / V \quad (2)$$

High-Voltage Operation (Output Capacitor)

During a hard short condition on the output while operating at greater than 24V V_{IN}, a large instantaneous inrush current is delivered to the shorted output. A capacitor must be placed at the OUTPUT pin, acting as a current source to support the instantaneous current draw (Table 2). A low-ESR capacitor is recommended. Once the value of the output capacitor is determined from Table 2, Equation 2 must be reevaluated.

Table 2. C_{OUT} Selection Guide

V_{IN} (V)	Capacitance (µF)
24< V_{IN} ≤ 27	22
27< V_{IN} ≤ 32	47
32< V_{IN} ≤ 36	68

Power Dissipation

During normal operation as a switch, the power dissipation of the device is small and has little effect on the operating temperature of the part. The maximum power dissipation for the switch in normal operation occurs just before the switch enters into current limit. This may be calculated using the equation:

$$P_{D_MAX\,(NormalOperation)} = (I_{LIM\,(Max)})^2 \times R_{ON\,(MAX)} \quad (3)$$

The maximum junction temperature should be limited to 125°C under normal operation. Junction temperature can be calculated using the equation:

$$T_J = P_D \times \Theta_{JA} + T_A \quad (4)$$

where:

- T_J is junction temperature;
- P_D is power dissipation on the switch;
- Θ_{JA} is the thermal resistance, junction-to-ambient of the package; and
- T_A is ambient temperature.

Design Example

For a 12V application and $I_{LIM\ (Max)}$ = 1A, maximum power dissipation in a normal operation is calculated as:

$$P_{D_MAX\,(NormalOperation)(VIN=12V)} = (1)^2 \times 0.140 = 140mW \quad (5)$$

FPF2702 $P_{D(Max)}$ during OC:

If device is in over-current condition and V_{OUT}>2V, power dissipation can be calculated as:

$$P_D = (V_{IN} - V_{OUT}) \times I_{LIM\,(Max)} \quad (6)$$

If device is in short-circuit current limit and V_{OUT} < 2V, power dissipation can be calculated as:

$$P_D = (V_{IN} - V_{OUT}) \times (0.75 \times I_{LIM\,(Max)}) \quad (7)$$

Design Example:

Using FPF2702 in a V_{IN} = 5V application where $I_{LIM\,(Max)}$ = 2A, assuming V_{OUT} = 2.5V; power dissipation across the switch is calculated as:

$$P_D = (5 - 2.5) \times 2 = 5W \quad (8)$$

Whereas in a short-circuit current-limit condition (V_{OUT} ≈ 0V), power dissipation is calculated as:

$$P_D = ((V_{IN} - V_{OUT}) \times (0.75 \times I_{LIM\,(Max)}) = (5 - 0) \times (0.75 \times 2) = 7.5W \quad (9)$$

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PCB Layout Recommendations

For the best performance, all traces should be as short as possible. To be most effective, the input and output capacitors should be placed close to the device to minimize the effects that parasitic trace inductances may have on normal and short-circuit operation (Figure 42). Using wide traces for IN, OUT, and GND pins helps minimize parasitic electrical effects as well as the case-to-ambient thermal impedance.

To minimize the interference between analog ground (chip ground, pin 5) and power ground during load current excursion, the ground terminal of the input and output capacitors and the R_{SET} resistor should be routed directly to chip ground and away from power ground.

Improving Thermal Performance

Improper layout could result in higher junction temperature and trigger thermal shutdown protection. This is particularly significant for the FPF2702, where the device operates in Constant Current Mode under overload conditions. During fault conditions, the power dissipation of the switch could exceed the maximum absolute power dissipation.

The following techniques improve the thermal performance of this family of devices. These techniques are listed in order of the significance of their impact.

1. Thermal performance of the load switch can be improved by connecting the Die Attach Pad (DAP) of the MLP 3x3 package to the GND plane of the PCB.
2. Embedding two exposed through-hole vias into the DAP provides a path for heat to transfer to the back GND plane of the PCB. A drill size of round, 15 mils (0.4mm) with 1-ounce copper plating is recommended for appropriate solder reflow. A smaller-size hole prevents the solder from penetrating into the via, resulting in device lift-up. Similarly, a larger hole consumes excessive solder and may result in voiding the DAP.

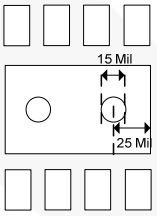


Figure 41. Two Through-Hole Open Vias Embedded in the DAP

3. The IN, OUT, and GND pins dissipate most of the heat generated during high-load current condition. The layout suggested in Figure 42 and Figure 43 is strongly recommended illustrating a proper layout for devices in MLP 3x3 packages. IN, OUT, and GND pins are connected to adequate copper so that heat may be transferred as efficiently as possible out of the device. The low-power FLAGB and ON pins traces may be laid-out diagonally from the device to maximize the area available to the ground pad. Place the input and output capacitors as close as possible to the device.

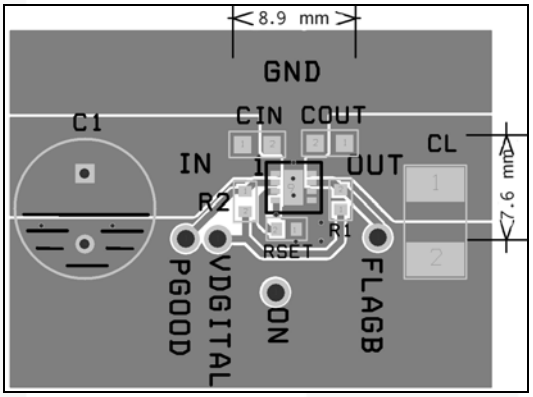


Figure 42. Proper Layout of Output and Ground Copper Area (Top, SST, and AST Layers)

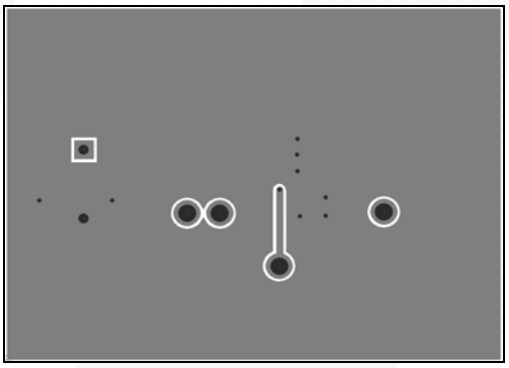


Figure 43. Proper Layout (Bottom and ASB Layers)

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FPF270x Demonstration Board

The FPF270X demonstration board has components and circuitry to demonstrate the load switch's functions and features. Thermal performance of the board is improved using the techniques recommended in the layout recommendations section. Additional information about demonstration board can be found in the FPF270X board users guide.

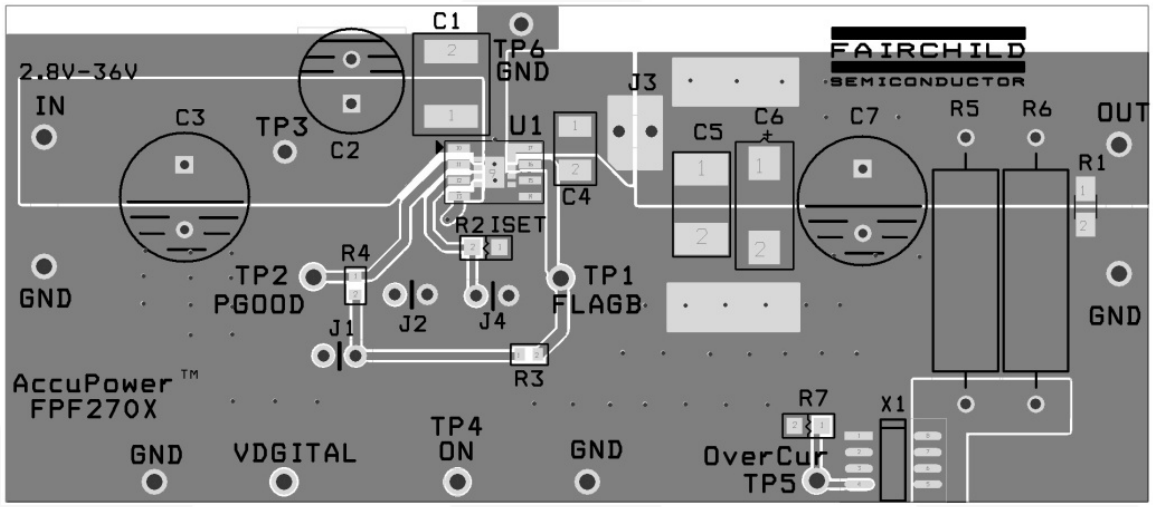


Figure 44. Top, SST, and AST Layers

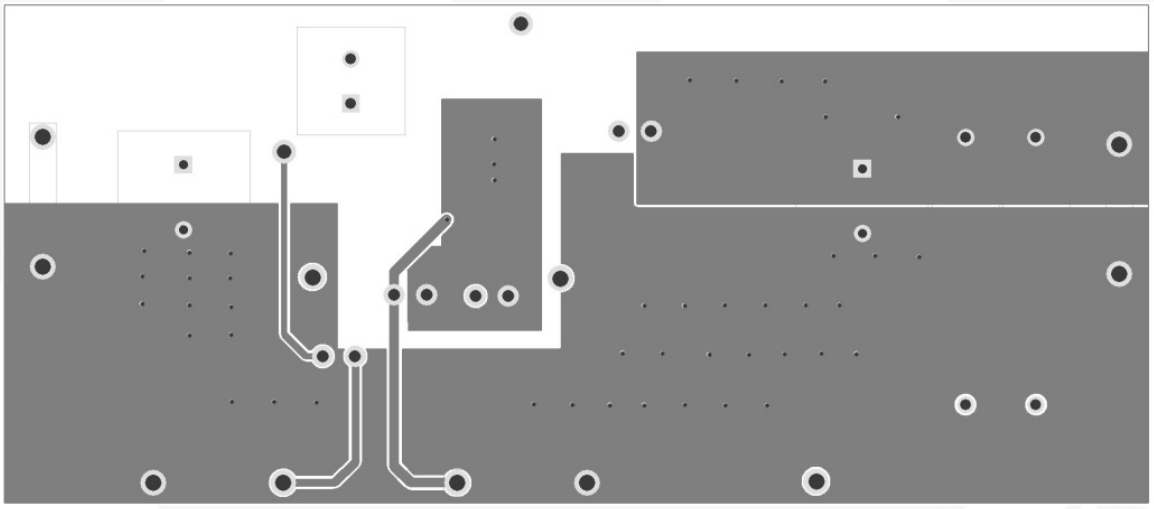


Figure 45. Bottom and ASB Layers

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Physical Dimensions

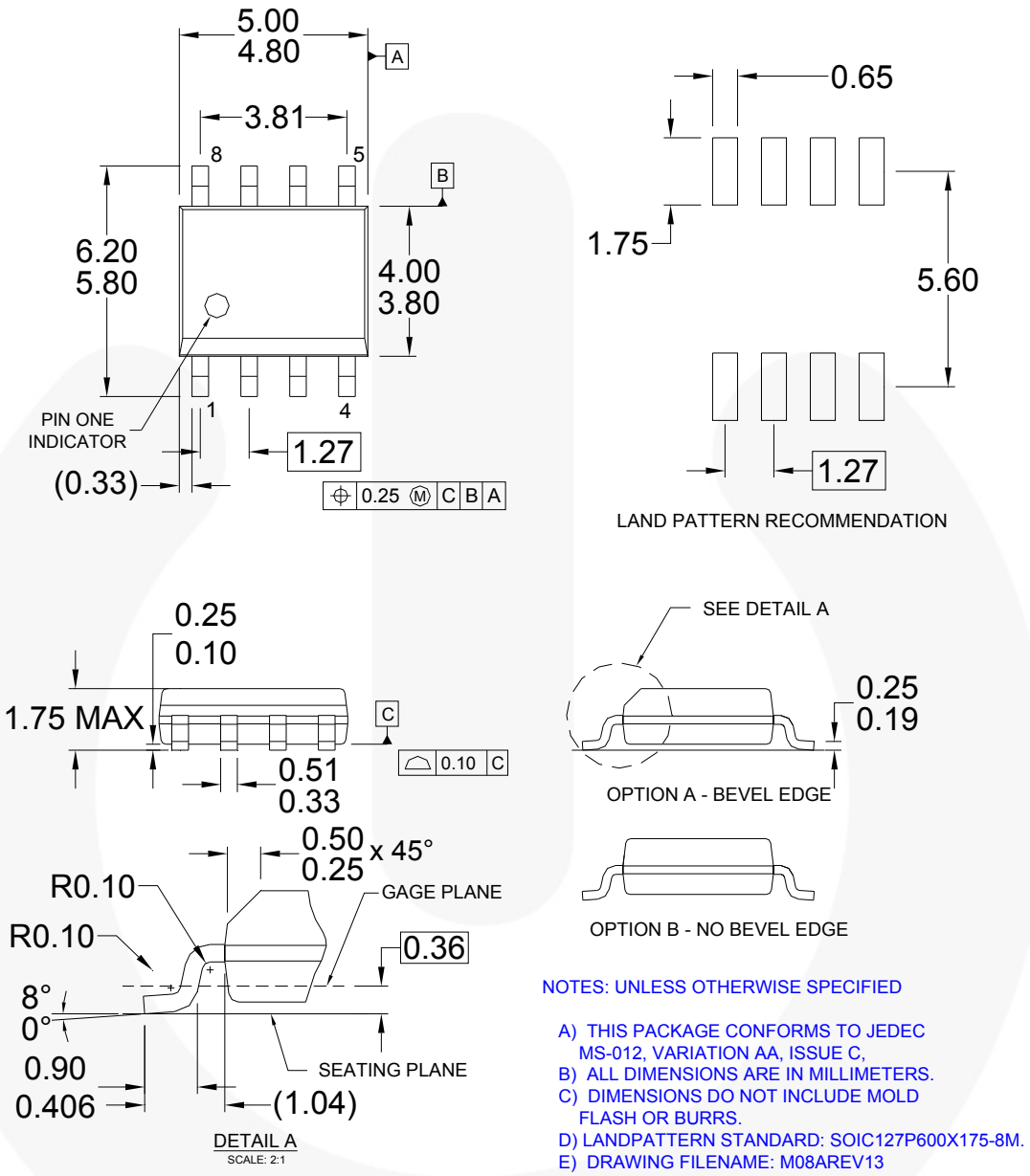


Figure 46. 8-Lead, Small Outline Package (SOP)

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Physical Dimensions

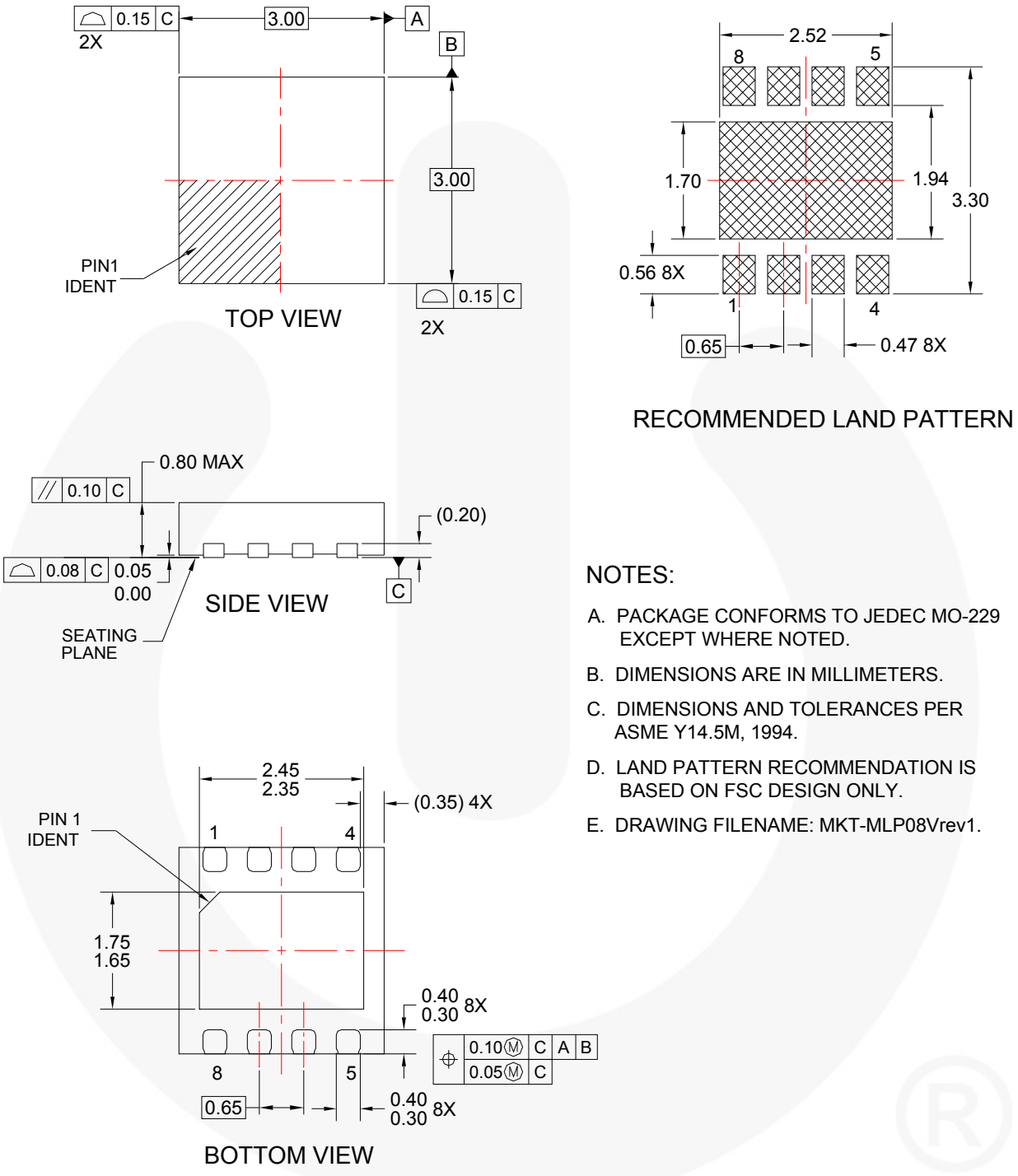


Figure 1. 8-Lead, 3x3mm Molded Leadless Package (MLP)

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